



PTO/SB/(08-03)

F10/SB/(08-03)

Approved for use through 07/31/2008. GPO 08-1003
U.S. Patent and Trademark Office, U.S. DEPARTMENT OF COMMERCE
Respond to a collection of information unless it displays a valid OMB control number.

Under the Paperwork Reduction Act of 1995, no persons are required to respond to a collection of information unless it displays a valid OMB control number.

Substitute for form 1449/PTO

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

Complete If Known	
Application Number	10/809,587
Filing Date	March 25, 2004
First Named Inventor	Childress et al.
Examiner Name	Unknown
Art Unit	2163 2155
Attorney Docket No.	AUS920040118US1

FOREIGN PATENT DOCUMENTS

Examiner Initial	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear

NON-PATENT LITERATURE

Examiner Initial		Include name of author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.
<i>JW</i>	AB	Augerat et al., "Scalable monitoring and configuration tools for grids and clusters", Parallel, Distributed and Network-Based Processing, 2002. Proceedings of the 10 th Euromicro Workshop January 2002, IEEE Comput. Soc., US, 2002, pp. 147-153.
	AC	Anderson et al., "Extensible, Scalable Monitoring for Clusters of Computers", Proceedings of the Eleventh Systems Administration Conference, October 1997, pp. 9-16.
	AD	Zhengyu et al., "ClusterProbe: an Open, Flexible and Scalable Cluster Monitoring Tool", IEEE Computer Society International Workshop on Cluster Computing, December 1999, pp. 1-8.
	AE	Buyya, "PARMON: A Portable and Scalable Monitoring System for Clusters", Software Practice & Experience, John Wiley & Sons Ltd., Chichester, GB, Vol. 30, No. 7, June 2000, pp. 723-739.
<i>↓</i>	AF	Haynes et al., "A Visualization Tool for Analyzing Cluster Performance Data", Proceedings of 2001 IEEE International Conference on Cluster Computer, Newport Beach, CA, pp. 295-302.

Examiner:

Ti-ch w-y

Date Considered:

9/12/07

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.